

# United States of America

United States Patent and Trademark Office



**Reg. No. 5,158,483**

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**Int. Cl.: 9, 41, 42**

**Service Mark**

**Trademark**

**Principal Register**

SPECS Surface Nano Analysis GmbH (GERMANY LIMITED LIABILITY COMPANY)  
Voltastr. 5  
13355 Berlin  
FED REP GERMANY

CLASS 9: SCIENTIFIC APPARATUS AND INSTRUMENTS, NAMELY, SPECTROSCOPES FOR ELECTRON SPECTROSCOPY, ION SPECTROSCOPY AND GAS AND ELEMENTAL ANALYSIS; [ MEASURING APPARATUS AND INSTRUMENTS FOR MATERIAL ANALYSIS WHICH USE METHODS FOR SPECTROSCOPY AND MICROSCOPY BASED ON ELECTRONS, IONS AND PHOTONS; ] \* MEASURING APPARATUS AND INSTRUMENTS FOR MATERIAL ANALYTICS USING SPECTROSCOPIC AND MICROSCOPIC METHODS BEING BASED ON ELECTRONS, IONS AND PHOTONS; \* EXCITATION SOURCES, IN PARTICULAR ELECTRON TUBES, LASERS FOR NON-MEDICAL PURPOSES, PULSE GENERATORS FOR TESTING ELECTRIC CURRENT, OPTICAL LAMPS AND LED LIGHT EMITTING DIODES, WITH ULTRAVIOLET LIGHT, X-RAYS AND ELECTRONS FOR USE IN SCIENTIFIC APPARATUS AND INSTRUMENTS; ACCESSORIES FOR SCIENTIFIC APPARATUS AND INSTRUMENTS AND FOR MEASURING APPARATUS AND INSTRUMENTS, namely, DEPTH GAUGES FOR SCANNING PROBE MICROSCOPES; PROBES AND SENSORS FOR USE WITH ELECTRON SPECTROSCOPY AND GAS ANALYSIS AND FOR MEASURING APPARATUS AND INSTRUMENTS FOR SCIENTIFIC PURPOSES; DATA PROCESSING APPARATUS \* FOR MATERIAL ANALYTICS USING SPECTROSCOPIC AND MICROSCOPIC METHODS BEING BASED ON ELECTRONS, IONS AND PHOTONS \* ; COMPUTER SOFTWARE FOR DATABASE MANAGEMENT; COMPUTER PROGRAMS FOR THE TRANSMISSION, PROCESSING, EDITING AND ANALYSIS OF DATA, AND COMPUTER PROGRAMS FOR THE CONTROL OF SCIENTIFIC APPARATUS AND INSTRUMENTS \* FOR MATERIAL ANALYTICS USING SPECTROSCOPIC AND MICROSCOPIC METHODS BEING BASED ON ELECTRONS, IONS AND PHOTONS \* ; [ ELECTRIC AND ELECTRONIC CONTROL APPARATUS AND INSTRUMENTS, IN PARTICULAR FOR THE CONTROL OF SCIENTIFIC APPARATUS AND INSTRUMENTS, IN PARTICULAR SPECTROSCOPES FOR ELECTRON SPECTROSCOPY, ION SPECTROSCOPY AND GAS AND ELEMENTAL ANALYSIS ] \* ELECTRIC AND ELECTRONIC CONTROL APPARATUS AND INSTRUMENTS, namely, FOR THE CONTROL OF SCIENTIFIC APPARATUS AND INSTRUMENTS FOR MATERIAL ANALYTICS USING SPECTROSCOPIC AND MICROSCOPIC METHODS BEING BASED ON ELECTRONS, IONS AND PHOTONS \*



*Joseph Matal*

Performing the Functions and Duties of the  
Under Secretary of Commerce for  
Intellectual Property and Director of the  
United States Patent and Trademark Office

CLASS 41: EDUCATIONAL SERVICES, NAMELY, CLASSES IN THE FIELD OF HANDLING AND OPERATING SCIENTIFIC APPARATUS AND INSTRUMENTS, IN PARTICULAR ELECTRON SPECTROMETERS; EDUCATIONAL SERVICES, NAMELY, ARRANGING AND CONDUCTING SEMINARS AND WORKSHOPS IN THE FIELD OF HANDLING AND OPERATING SCIENTIFIC APPARATUS AND

INSTRUMENTS, IN PARTICULAR ELECTRON SPECTROMETERS, FOR EDUCATIONAL PURPOSES; TRAINING ADVICE IN THE FIELD OF HANDLING AND OPERATING SCIENTIFIC APPARATUS AND INSTRUMENTS, IN PARTICULAR ELECTRON SPECTROMETERS

CLASS 42: [ SCIENTIFIC AND TECHNOLOGICAL SERVICES, NAMELY, RESEARCH AND DESIGN RELATED TO THE ANALYSIS OF SURFACES IN RELATION TO THE DESIGN, ASSEMBLY AND OPERATION OF MEASURING APPARATUS AND INSTRUMENTS FOR MATERIAL ANALYSIS WHICH USE METHODS FOR SPECTROSCOPY AND MICROSCOPY BASED ON ELECTRONS, IONS AND PHOTONS; RESEARCH IN THE FIELD OF SEMICONDUCTOR PROCESSING TECHNOLOGY; INDUSTRIAL ANALYSIS AND RESEARCH SERVICES IN THE FIELD OF SURFACES OF MATERIALS; ] \* SCIENTIFIC AND TECHNOLOGICAL SERVICES AND RESEARCH AND RELATED DESIGN SERVICES RELATED TO THE ANALYSIS OF SURFACES, EACH SERVICES IN CONNECTION WITH THE DESIGN, THE INSTALLATION AND THE OPERATION OF MEASURING APPARATUS AND INSTRUMENTS FOR MATERIAL ANALYTICS USING SPECTROSCOPIC AND MICROSCOPIC METHODS BEING BASED ON ELECTRONS, IONS AND PHOTONS; RESEARCH IN THE FIELD OF TECHNOLOGY FOR ANALYZING SURFACES; INDUSTRIAL ANALYSIS AND RESEARCH SERVICES RELATING TO MATERIAL SURFACES \* DESIGN AND DEVELOPMENT OF COMPUTER HARDWARE AND SOFTWARE, IN PARTICULAR DESIGN AND DEVELOPMENT OF COMPUTER HARDWARE AND SOFTWARE FOR TRANSMISSION, PROCESSING, EDITING AND ANALYSIS OF DATA AND COMPUTER PROGRAMS FOR CONTROL OF SCIENTIFIC APPARATUS AND INSTRUMENTS \* FOR ANALYZING SURFACES \* ; UPDATING COMPUTER SOFTWARE, IN PARTICULAR UPDATING COMPUTER SOFTWARE FOR TRANSMISSION, PROCESSING, EDITING AND ANALYSIS OF DATA \* WHEN ANALYZING SURFACES \* AND UPDATING OF COMPUTER PROGRAMS FOR THE CONTROL OF SCIENTIFIC APPARATUS AND INSTRUMENTS \* FOR ANALYZING SURFACES \* ; ENGINEERING AND PHYSICS RESEARCH \* FOR ANALYZING SURFACES \* ; ENGINEERING SERVICES, PARTICULARLY TECHNICAL PROJECT PLANNING [ AND DESIGN ENGINEERING FOR THE PROCESSING OF WEB PRODUCTS] \* IN CONNECTION WITH THE DESIGN, THE INSTALLATION AND THE OPERATION OF MEASURING APPARATUS AND INSTRUMENTS FOR MATERIAL ANALYTICS USING SPECTROSCOPIC AND MICROSCOPIC METHODS BEING BASED ON ELECTRONS, IONS AND PHOTONS \*

The color(s) dark blue, medium blue, light blue, light green and dark green is/are claimed as a feature of the mark.

The mark consists of the wording "ENVIRO" in dark blue block lettering with a design element composed of 3 stylized leaves to the upper right of the letter "E". One leaf is entirely dark blue, the leaf to its right is light green and dark green and the leaf directly below the dark blue leaf is medium blue and light blue.

PRIORITY DATE OF 10-07-2015 IS CLAIMED

OWNER OF INTERNATIONAL REGISTRATION 1302957 DATED 03-18-2016, EXPIRES 03-18-2026

SER. NO. 79-189,104, FILED 03-18-2016

**REQUIREMENTS TO MAINTAIN YOUR FEDERAL TRADEMARK REGISTRATION**

**WARNING: YOUR REGISTRATION WILL BE CANCELLED IF YOU DO NOT FILE THE DOCUMENTS BELOW DURING THE SPECIFIED TIME PERIODS.**

**Requirements in the First Ten Years\***

**What and When to File:**

- **First Filing Deadline:** You must file a Declaration of Use (or Excusable Nonuse) between the 5th and 6th years after the registration date. See 15 U.S.C. §§1058, 1141k. If the declaration is accepted, the registration will continue in force for the remainder of the ten-year period, calculated from the registration date, unless cancelled by an order of the Commissioner for Trademarks or a federal court.
- **Second Filing Deadline:** You must file a Declaration of Use (or Excusable Nonuse) and an Application for Renewal between the 9th and 10th years after the registration date.\* See 15 U.S.C. §1059.

**Requirements in Successive Ten-Year Periods\***

**What and When to File:**

- You must file a Declaration of Use (or Excusable Nonuse) and an Application for Renewal between every 9th and 10th-year period, calculated from the registration date.\*

**Grace Period Filings\***

The above documents will be accepted as timely if filed within six months after the deadlines listed above with the payment of an additional fee.

**\*ATTENTION MADRID PROTOCOL REGISTRANTS:** The holder of an international registration with an extension of protection to the United States under the Madrid Protocol must timely file the Declarations of Use (or Excusable Nonuse) referenced above directly with the United States Patent and Trademark Office (USPTO). The time periods for filing are based on the U.S. registration date (not the international registration date). The deadlines and grace periods for the Declarations of Use (or Excusable Nonuse) are identical to those for nationally issued registrations. See 15 U.S.C. §§1058, 1141k. However, owners of international registrations do not file renewal applications at the USPTO. Instead, the holder must file a renewal of the underlying international registration at the International Bureau of the World Intellectual Property Organization, under Article 7 of the Madrid Protocol, before the expiration of each ten-year term of protection, calculated from the date of the international registration. See 15 U.S.C. §1141j. For more information and renewal forms for the international registration, see <http://www.wipo.int/madrid/en/>.

**NOTE: Fees and requirements for maintaining registrations are subject to change. Please check the USPTO website for further information. With the exception of renewal applications for registered extensions of protection, you can file the registration maintenance documents referenced above online at <http://www.uspto.gov>.**

**NOTE: A courtesy e-mail reminder of USPTO maintenance filing deadlines will be sent to trademark owners/holders who authorize e-mail communication and maintain a current e-mail address with the USPTO. To ensure that e-mail is authorized and your address is current, please use the Trademark Electronic Application System (TEAS) Correspondence Address and Change of Owner Address Forms available at <http://www.uspto.gov>.**